

PERRY JOHNSON LABORATORY ACCREDITATION, INC.

Certificate of Accreditation

Perry Johnson Laboratory Accreditation, Inc. has assessed the Laboratory of:

United Electronic Industries, Inc.

249 Vanderbilt Ave, Norwood, MA 02062

(Hereinafter called the Organization) and hereby declares that Organization is accredited in accordance with the recognized International Standard:

ISO/IEC 17025:2017

This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (as outlined by the joint ISO-ILAC-IAF Communiqué dated April 2017):

Electrical Calibration (As detailed in the supplement)

Accreditation claims for such testing and/or calibration services shall only be made from addresses referenced within this certificate. This Accreditation is granted subject to the system rules governing the Accreditation referred to above, and the Organization hereby covenants with the Accreditation body's duty to observe and comply with the said rules.

For PJLA:

President

Tracy Szerszen

Perry Johnson Laboratory Accreditation, Inc. (PJLA) 755 W. Big Beaver, Suite 1325 Troy, Michigan 48084 Initial Accreditation Date: Issue Date: Expiration Date:

May 08, 2018 May 29, 2022 August 31, 2024

Revision Date: Accreditation No.: Certificate No.:

June 07, 2023 90811 L22-400-R1

The validity of this certificate is maintained through ongoing assessments based on a continuous accreditation cycle. The validity of this certificate should be confirmed through the PJLA website; www.pjlabs.com





Certificate of Accreditation: Supplement

United Electronic Industries, Inc.

249 Vanderbilt Ave, Norwood, MA 02062 Contact Name: Mr. Greg Tailefer Phone: 508-921-4600

Accreditation is granted to the facility to perform the following calibrations:

Electrical

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Equipment to Measure DC Volts ^F	12 V to 120 V	37 uV + 12 uV/V	3458A WI: OEM LP-4 EAI015
	1.2 V to 11.9 V	4.9 uV + 9.4 uV/V	
	120 mV to 1.19 V	2.5 uV + 9.9 uV/V	
	10 nV to 119 mV	3.2 uV + 7.8 uV/V	
Equipment to Measure DC Amps ^F	120 mA to 1.05 A	0.017 mA + 0.21mA/A	
	12 mA to 119 mA	0.62 uA + 0.058 uA/mA	
	10 nA to 11.9 mA	0.48 uA + 0.001 2 uA/mA	
Equipment to Measure AC Volts (RMS) ^F 45Hz – 5kHz	12 V to 120 V	43 mV + 0.000 1 mV/V	
	1.2 V to 11.9 V	3 mV + 0.005 mV/V	
	120 m V to 1.19 V	0.78 mV + 0.33 mV/V	
Equipment to Measure AC Amps (RMS) ^F 45Hz – 5kHz	120 mA to 1.05 A	1.4 mA + 0.001 8 mA/A	
	12 mA to 119 mA	60 uA + 0 uA/mA	
	10 nA to 11.9 mA	6 uA + 0 uA/mA	
Equipment to Measure Resistance ^F	$1.2~\mathrm{M}\Omega$ to $12~\mathrm{M}\Omega$	$840 \Omega + 0.000 21 \Omega/\Omega$	
	120 kΩ to 1.19 MΩ	$300 \Omega + 0.7 \mathrm{u}\Omega/\Omega$	
	12 kΩ to $119 kΩ$	$0.1 \Omega + 73 \mathrm{u}\Omega/\Omega$	
	$1.2 \text{ k}\Omega$ to $11.9 \text{ k}\Omega$	$0.19 \Omega + 0.012 \mathrm{u}\Omega/\Omega$	
	120 Ω to 1.19 k Ω	$0.021 \Omega + 0.18 \mathrm{u}\Omega/\Omega$	
	12 Ω to 119 Ω	$0.036 \Omega + 3.2 \mathrm{u}\Omega/\Omega$	
	10 u Ω to 11.9 Ω	$0.006 3 \Omega - 25 u\Omega/\Omega$	

- 1. The CMC (Calibration and Measurement Capability) stated for calibrations included on this scope of accreditation represents the smallest measurement uncertainty attainable by the laboratory when performing a more or less routine calibration of a nearly ideal device under nearly ideal conditions. It is typically expressed at a confidence level of 95 % using a coverage factor k (usually equal to 2). The actual measurement uncertainty associated with a specific calibration performed by the laboratory will typically be larger than the CMC for the same calibration since capability and performance of the device being calibrated and the conditions related to the calibration may reasonably be expected to deviate from ideal to some degree.
- 2. The laboratories range of calibration capability for all disciplines for which they are accredited is the interval from the smallest calibrated standard to the largest calibrated standard used in performing the calibration. The low end of this range must be an attainable value for which the laboratory has or has access to the standard referenced. Verification of an indicated value of zero in the absence of a standard is common practice in the procedure for many calibrations but by its definition it does not constitute calibration of zero capacity.
- 3. The presence of a superscript F means that the laboratory performs calibration of the indicated parameter at its fixed location. Example: Outside Micrometer^F would mean that the laboratory performs this calibration at its fixed location.